Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/775,543	SUNG, CHIEN-MIN	
Examiner	Art Unit	-
Marcos D. Pizarro-Crespo	2814	

	SEARCHED					
Class	Subclass	Date	Examiner			
257	77,706 707 712-722 E23.111	4/30/2005	MDP			

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
257	77,706 707				
	712-722	4/30/2005	MDP		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
PLUS Analysis made of record. 10/270,018 10/453,469 10/769,554	4/30/2005	MDP		
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